IN THE CLAIMS

The status of each claim in the present application is listed below.

Claims 1-16: (Canceled).

17. (New) A process for producing a purified resist polymer solution, comprising:

(1) dissolving a solid product comprising a resist polymer comprising a repeating unit

decomposable by, and becoming alkali-soluble by, the action of an acid and a polar group-

containing repeating unit, in a solvent (b) comprising one or more solvents selected from the

group consisting of acetone, methyl ethyl ketone, tetrahydrofuran, ethylene glycol dimethyl

ether, and ethyl acetate, and

(2) evaporating from the solution obtained in (1) the solvent (b) while adding, under

reduced pressure with the temperature being controlled at 70°C or less, a solvent (a)

comprising one or more solvents selected from the group consisting of propylene glycol

monomethyl ether acetate, ethyl lactate, cyclohexanone, methyl amyl ketone, diethylene

glycol dimethyl ether, diethylene glycol monoethyl ether, and γ -butyrolactone,

wherein the boiling point of solvent (b) is not higher than the boiling point of solvent

(a) at atmospheric pressure, and

wherein the amount of impurities having a boiling point at atmospheric pressure of

not more than the boiling point of the solvent (a) is 1 mass% or less of the resist polymer in

the purified resist polymer solution.

18. (New) The process of Claim 17, wherein the repeating unit decomposable by the

action of an acid and becoming alkali-soluble contains an alicyclic skeleton having 5-20

carbon atoms.

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- 19. (New) The process of Claim 17, wherein the polar group-containing repeating unit comprises at least one polar group selected from the group consisting of a phenolic hydroxyl group, carboxyl group, hydroxyfluoroalkyl group, lactone structure, and hydroxyalkyl group.
- 20. (New) The process of Claim 17, wherein the amount of the resist polymer in the resist polymer solution is in a range of 5-50 mass%.
- 21. (New) The process of Claim 17, wherein the amount of the resist polymer in the resist polymer solution is in a range of 10-30 mass%.
- 22. (New) The process of Claim 17, wherein the rate of dissolution of the resist polymer in the solvent (b) is greater than the rate of dissolution of the resist polymer in the solvent (a).
- 23. (New) The process of Claim 17, wherein (2) is conducted with the temperature being controlled at 60°C or less.
- 24. (New) The process of Claim 17, wherein (2) is conducted with the temperature being controlled at 55°C or less.
- 25. (New) The process of Claim 17, wherein the amount of impurities having a boiling point at atmospheric pressure of not more than the boiling point of the solvent (b) is 0.5 mass% or less of the resist polymer in the purified resist polymer solution.